

Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 129526		APPLICATION NO. 10/594,061	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)				APPLICANT(S) Yuichi SHIBAZAKI			
				FILING DATE December 22, 2006		GROUP 2851	

U.S. PATENT DOCUMENTS				
Examiner Initials	Cite No.	Document Number	Date	Name
	1.	5,448,332	09/05/1995	SAKAKIBARA et al.
	2.	5,243,195	09/07/1993	NISHI
	3.	2002/0041377 A1	04/11/2002	HAGIWARA et al.
	4.	4,465,368	08/14/1984	MATSUURA et al.
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	7.	2006/0285092 A1	12/21/2006	ONO
	8.	5,646,413	07/08/1997	NISHI
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	11.	4,346,164	08/24/1982	TABARELLI et al.
	12.	4,480,910	11/06/1984	TAKANASHI et al.
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	15.	5,825,043	10/20/1998	SUWA
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	17.	JP A 6-84757	03/25/1994	JAPAN	X	X
	18.	JP A 2005-129914	05/19/2005	JAPAN	X	X
	19.	JP A 2004-61177	02/26/2004	JAPAN	X	X
	20.	JP A 11-87237	03/30/1999	JAPAN	X	X

OTHER DOCUMENTS		
Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER	DATE CONSIDERED
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

Date: September 20, 2007

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